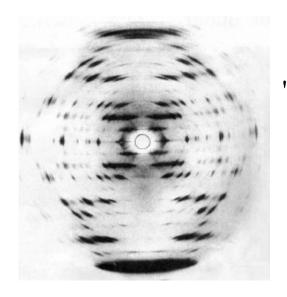


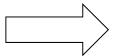
Technische Universität Graz

10. Crystal Diffraction

crystal structure solution



"Guess" the crystal structure



Element	Z	a_1	a ₂	аз	a4	a ₅	b_1	b_2	b_3
Н	1	0.0349	0.1201	0.1970	0.0573	0.1195	0.5347	3.5867	12.347
He	2	0.0317	0.0838	0.1526	0.1334	0.0164	0.2507	1.4751	4.493
Li	3	0.0750	0.2249	0.5548	1.4954	0.9354	0.3864	2.9383	15.38
Ве	4	0.0780	0.2210	0.6740	1.3867	0.6925	0.3131	2.2381	10.15
В	5	0.0909	0.2551	0.7738	1.2136	0.4606	0.2995	2.1155	8.381
C	6	0.0893	0.2563	0.7570	1.0487	0.3575	0.2465	1.7100	6.409
N	7	0.1022	0.3219	0.7982	0.8197	0.1715	0.2451	1.7481	6.192
0	8	0.0974	0.2921	0.6910	0.6990	0.2039	0.2067	1.3815	4.694
F	9	0.1083	0.3175	0.6487	0.5846	0.1421	0.2057	1.3439	4.278
Ne	10	0.1269	0.3535	0.5582	0.4674	0.1460	0.2200	1.3779	4.020
Na	11	0.2142	0.6853	0.7692	1.6589	1.4482	0.3334	2.3446	10.08
Mg	12	0.2314	0.6866	0.9677	2.1882	1.1339	0.3278	2.2720	10.92
A1	13	0.2390	0.6573	1.2011	2.5586	1.2312	0.3138	2.1063	10.41
Si	14	0.2519	0.6372	1.3795	2.5082	1.0500	0.3075	2.0174	9.674
P	15	0.2548	0.6106	1.4541	2.3204	0.8477	0.2908	1.8740	8.517
S	16	0.2497	0.5628	1.3899	2.1865	0.7715	0.2681	1.6711	7.026
C1	17	0.2443	0.5397	1.3919	2.0197	0.6621	0.2468	1.5242	6.153
Ar	18	0.2385	0.5017	1.3428	1.8899	0.6079	0.2289	1.3694	5.256
	1.0	l		0.0004	0.4040	0.0440	0.0000	0.0004	

Compare $|S_G|^2$ to the

measurements

From the atomic form factors, calculate the structure factors n_G .

$$S_{ec{G}} = \sum_{j} f_{j}(G) e^{-i ec{G} \cdot ec{r}_{j}}$$

Sum over basis

position of atom *j* of the basis

x-ray diffraction

The shape and the dimensions of the unit cell can be deduced from the positions of the Bragg reflections; the content of the unit cell, on the other hand, must be determined from the intensities of the reflections.

Solid State Physics, Ibach and Lüth

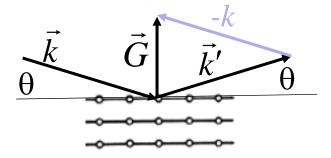
Diffraction condition:
$$\Delta \vec{k} = \vec{G}$$

The intensity of the peaks is proportional to the squared Fourier coefficients of the electron density.

$$S_{ec{G}} = \sum_{j} f_{j}(G) e^{-i ec{G} \cdot ec{r}_{j}}$$

x-ray diffraction

$$ec{G}_{hkl} \perp (hkl)$$



for
$$\theta = \pi/2$$
, $2|k| = |G|$ and

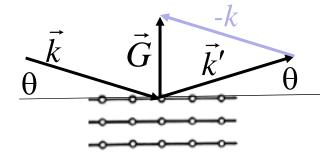
constructive interference takes place when $2d_{hkl} = \lambda$.

$$\frac{\left|\vec{G}_{hkl}\right|}{2} = \frac{2\pi}{2d_{hkl}} = \frac{2\pi}{\lambda} = \left|\vec{k}\right|$$

$$\left| \vec{G}_{hkl} \right| = \frac{2\pi}{d_{hkl}}$$

x-ray diffraction

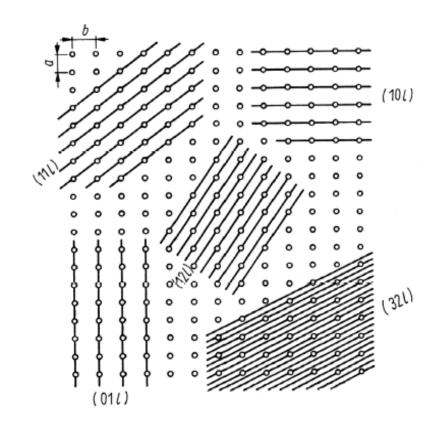
$$ec{G}_{hkl} \perp (hkl)$$



$$\left| \vec{G}_{hkl} \right| = \left| \Delta \vec{k} \right| = 2 \left| \vec{k} \right| \sin \theta = \frac{2\pi}{d_{hkl}}$$

$$\left| \vec{G}_{hkl} \right| = \frac{2\pi}{d_{hkl}} \qquad \left| \vec{k} \right| = \frac{2\pi}{\lambda}$$

$$\left| \vec{k} \right| = \frac{2\pi}{\lambda}$$



distance between the net planes

$$2d_{hkl}\sin\theta = \lambda$$

 $2d_{hkl}\sin\theta = \lambda$ another formulation of the diffraction condition

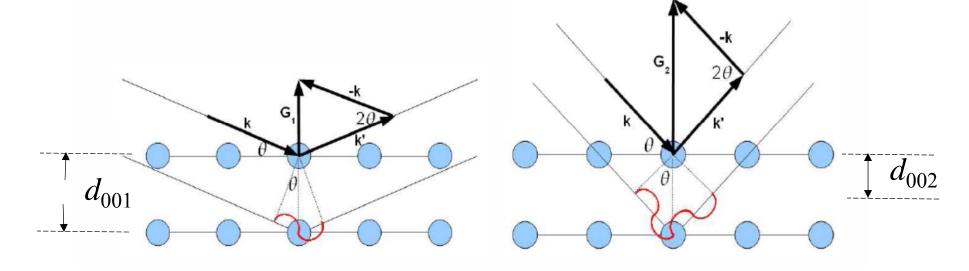
Bragg and Laue conditions

Bragg condition: $2d \sin \theta = n\lambda$

Laue condition:

$$\Delta \vec{k} = \vec{G} = h\vec{b_1} + k\vec{b_2} + l\vec{b_3}$$

$$2d_{hkl}\sin\theta = \lambda$$

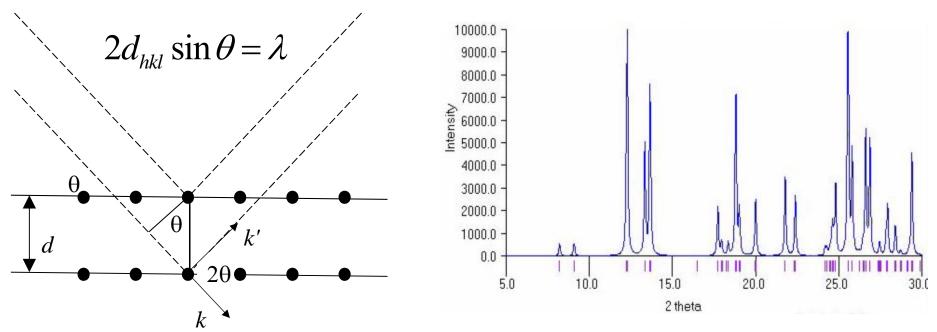


$$n = 1 \Leftrightarrow 001$$

$$n = 2 \Leftrightarrow 002$$

Powder diffraction

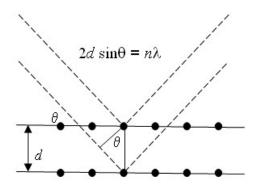
Powder diffraction is performed on a powder of many small crystals. Ideally, every possible crystalline orientation is represented equally in a powdered sample. The relative intensities of the diffraction peaks indicate which crystal structures are present.



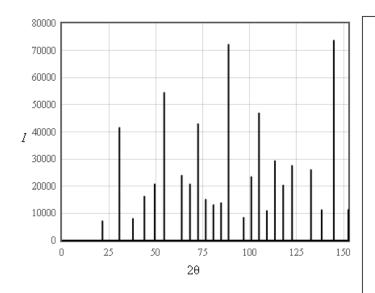
X-rays: Bragg diffraction

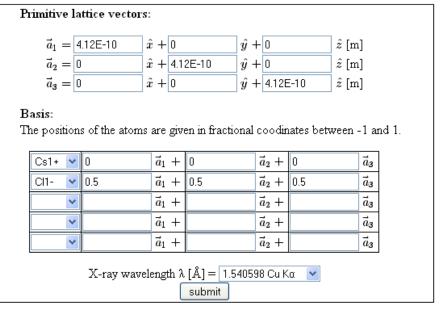
Powder diffraction

For powder diffraction, a crystal is ground into a fine powder so that there are many small crystals with random orientations. X-rays strike the surface of the sample at an angle θ and an x-ray detector is placed at an angle θ to the surface. Only planes parallel to the surface will diffract x-rays to the detector.

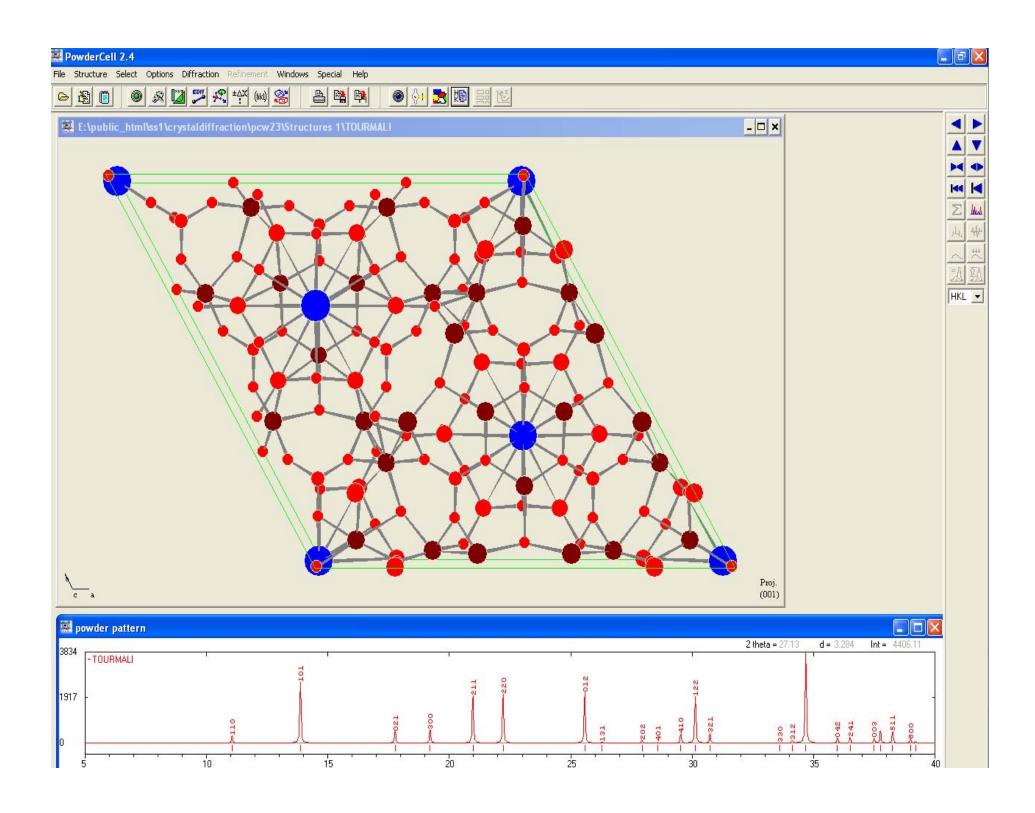


Since there are many small crystals with random orientations in the sample, all possible crystal planes that can diffract the x-rays will contribute to the measured signal when θ satisfies the Bragg condition. The form below can calculate the powder diffraction pattern for any crystal with up to five atoms per primitive unit cell. Some buttons are provided that load the form with the data for certain crystals.

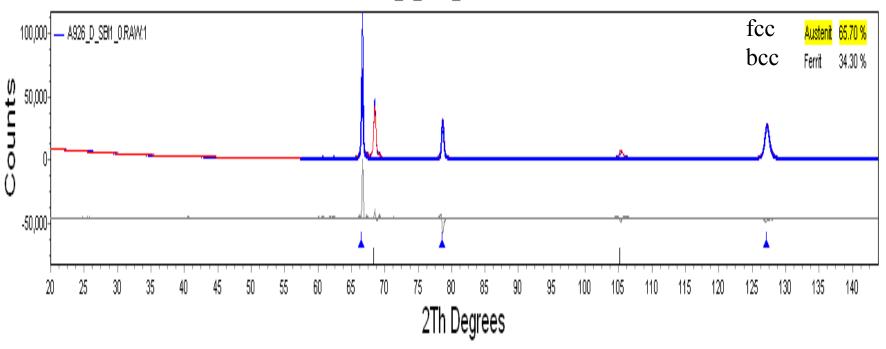


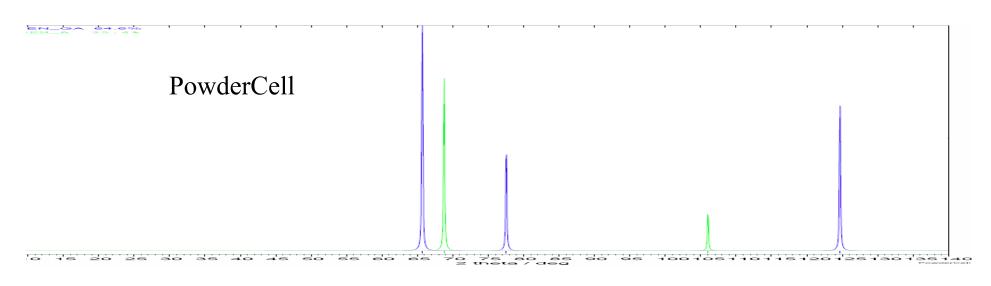


Al (fcc) NaCl (fcc) CsCl (sc) SrTiO3 (perovskite, sc) GaAs (Zincblend, fcc) GaN (Wurtzite, hex)

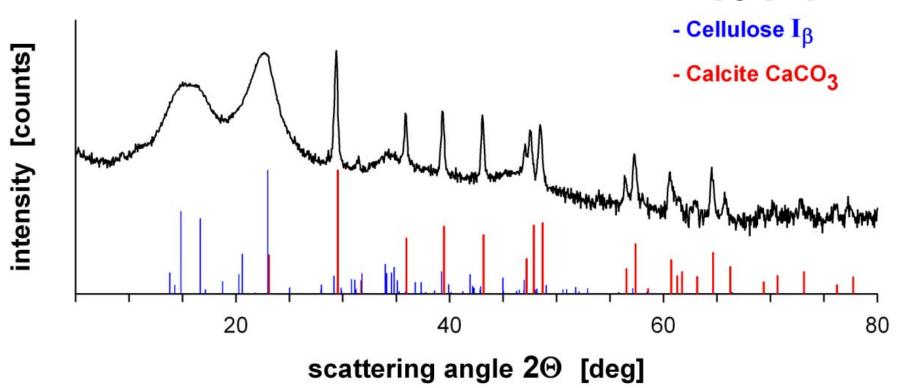








copy paper



Powder diffraction

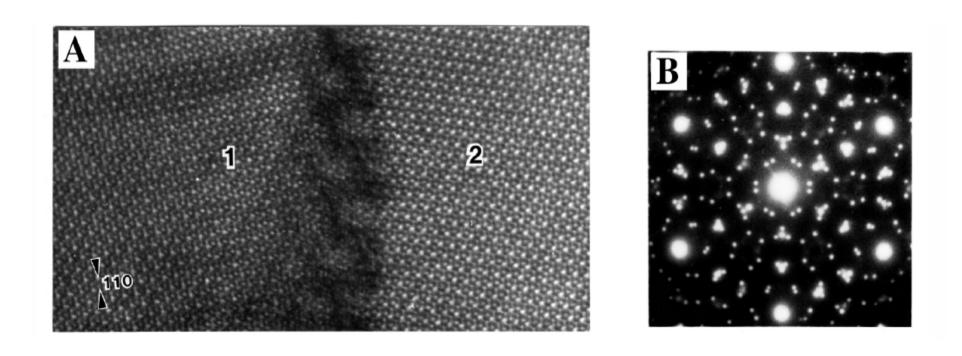
Phase identification

Every crystal has a specific "fingerprint" given by the positions and intensities of the diffraction peaks. The composition of a multi-phase specimen can be determined by fitting its diffraction pattern to the diffraction patterns of pure crystals which can be looked up in a database.

International Centre for Diffraction Data www.icdd.com 550,000 reference materials

Phase transitions, thermal expansion, piezoelectricity, piezomagnetism, bulk modulus, compliance tensor can be measured.

Electron diffraction in a TEM



The wavelength of the electrons is typically much smaller than the lattice spacing. The diffraction peaks in the plane perpendicular to k are observed.

Electron diffraction

In electron diffraction, the intensity of a diffraction peak at reciprocal lattice vector \vec{G} is the square of the structure factor, $n_{\vec{G}}$.

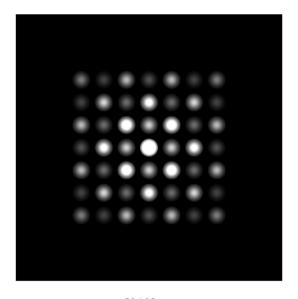
$$n_{\vec{G}} = \frac{1}{V} \sum_j f_j \Big(\vec{G} \Big) e^{-i \vec{G} \cdot \vec{r}_j} = \frac{1}{V} \sum_j f_j \Big(\vec{G} \Big) \Big(\cos \Big(\vec{G} \cdot \vec{r}_j \Big) - i \sin \Big(\vec{G} \cdot \vec{r}_j \Big) \Big)$$

Here V is the volume of the primitive unit cell, j sums over the atoms in the basis, \vec{r}_j are the positions of the atoms in the basis, and $f_j(\vec{G})$ are the electron atomic form factors evaluated at \vec{G} .

The form below calculates the electron structure factors based on this formula. The crystal structure is specified by providing the primitive lattice vectors and the positions of the atoms in the basis. A basis of up to five atoms can be calculated. The script first calculates the primitive reciprocal lattice vectors and from them calculates the reciprocal lattice vectors $\vec{G}_{hkl} = h\vec{b}_1 + k\vec{b}_2 + l\vec{b}_3$.

On this page, the direction of the incoming electrons is given in terms of the primitive lattice vectors in reciprocal space, $H\vec{b}_1 + K\vec{b}_2 + L\vec{b}_3$. Usually the direction of the incoming electrons are given in terms of the conventional lattice vectors. Be aware that the [100] is a (usually) different direction if primitive lattice vectors are used than if conventional lattice vectors are used.





[010] →

Primitive lattice vectors:

$\vec{a}_1 =$	4.12E-10	\hat{x} +	0	\hat{y} +	0	\hat{z} [m]
$\vec{a}_2 =$	0	\hat{x} +	4.12E-10	\hat{y} +	0	\hat{z} [m]
$\vec{a}_3 =$	0	\hat{x} +	0	\hat{y} +	4.12E-10	\hat{z} [m]

Basis:

The positions of the atoms are given in fractional coordinates between -1 and 1.

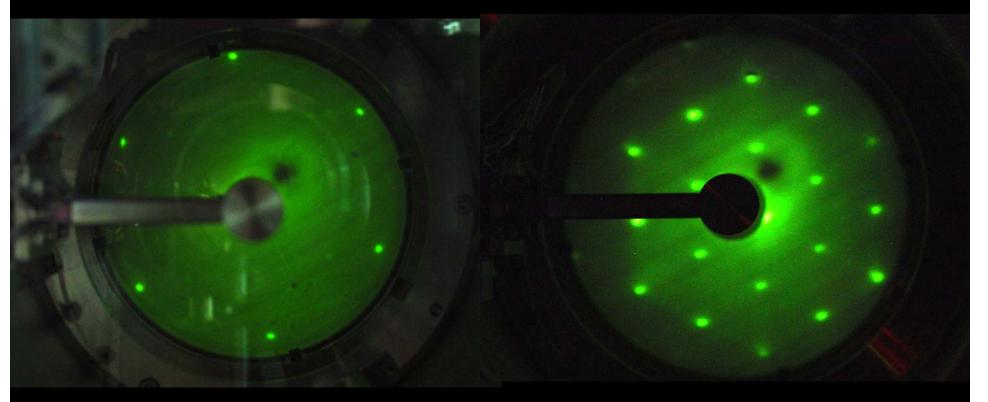
Cs 💌	0	\vec{a}_1 +	0	$ \vec{a}_2 +$	0	\vec{a}_3
CI 💌	0.5	\vec{a}_1 +	0.5	$ \vec{a}_2 +$	0.5	\vec{a}_3
~		\vec{a}_1 +		$ \vec{a}_2 +$		\vec{a}_3
~		\vec{a}_1 +		$ \vec{a}_2 +$		\vec{a}_3
~		\vec{a}_1 +		$ \vec{a}_2 +$		\vec{a}_3

submit

LEED

Low Energy Electron Diffraction

 $100 \text{ V} \rightarrow k \sim 5 \times 10^{10} \text{ m}^{-1}$



Clean Pd (111)

$$Pd (111) + 0.3 ML VO_x$$

LEED is surface sensitive

LEED

Energy of the electron beam: 100

[eV]

Primitive lattice vectors:

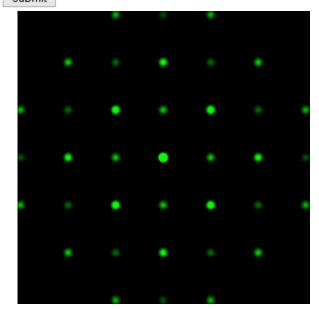
$$\vec{a}_1 = \boxed{4.12\text{E-}10} \quad \hat{x} + \boxed{0} \quad \hat{y} \text{ [m]}$$
 $\vec{a}_2 = \boxed{0} \quad \hat{x} + \boxed{4.12\text{E-}10} \quad \hat{y} \text{ [m]}$

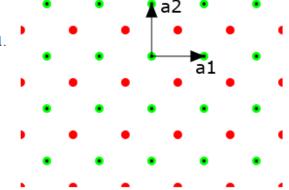
Basis:

The positions of the atoms are given in fractional coodinates between -1 and 1.

Cs v	0	$ \vec{a}_1 +$	0	$ec{a}_2$	
CI v	0.5	$ \vec{a}_1 +$	0.5	$ec{a}_2$	
~		$ \vec{a}_1 +$		$ec{a}_2$	
~		$ \vec{a}_1 +$		$ec{a}_2$	
~		$ \vec{a}_1 +$		$ec{a}_2$	

submit





Forbidden reflections

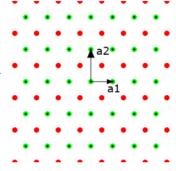
Primitive lattice vectors:

$$\vec{a}_1 = 4.12 \text{E-} 10$$
 $\hat{x} + 0$ \hat{y} [m] $\vec{a}_2 = 0$ $\hat{x} + 6.12 \text{E-} 10$ \hat{y} [m]

Basis

The positions of the atoms are given in fractional coodinates between -1 and 1.

C 🗸	0	\vec{a}_1 +	0	\vec{a}_2	
C v	0.5	$ \vec{a}_1 $	0.5	\vec{a}_2	
	0.2	$ \vec{a}_1 $	0.3	\vec{a}_2	
		$ \vec{a}_1 $		\vec{a}_2	
~		$ \vec{a}_1 $		\vec{a}_2	

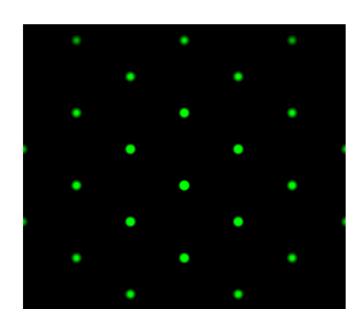


submit

Primitive reciprocal lattice vectors

$$\begin{split} \vec{b}_1 &= 2\pi \; \frac{R \, \vec{a}_2}{\vec{a}_1 \cdot R \, \vec{a}_2} = 1.525 \mathrm{e} + 10 \; \hat{k}_x + 0.000 \; \hat{k}_y \; [\mathrm{m}^{-1}] \\ \vec{b}_2 &= 2\pi \; \frac{R \, \vec{a}_1}{\vec{a}_1 \cdot R \, \vec{a}_2} = 0.000 \; \hat{k}_x + -1.027 \mathrm{e} + 10 \; \hat{k}_y \; [\mathrm{m}^{-1}] \\ \mathrm{with} \qquad R &= \; \begin{pmatrix} 0 & -1 \\ 1 & 0 \end{pmatrix} \end{split}$$

Low Energy Electron Diffraction



Forbidden reflections

$$n_{u.c.}(ec{r}) = \sum_j Z_j \delta(ec{r} - ec{r}_j).$$

Primitive reciprocal lattice vectors

$$\begin{split} \vec{b}_1 &= 2\pi \, \frac{\vec{a}_2 \times \vec{a}_3}{\vec{a}_1 \cdot (\vec{a}_2 \times \vec{a}_3)} \, = & 3.939 \, \hat{k}_x \, + \, -2.275 \mathrm{e} + 10 \, \hat{k}_y \, + \, 0.000 \, \hat{k}_z \, [\mathrm{m}^{-1}] \\ \vec{b}_2 &= 2\pi \, \frac{\vec{a}_3 \times \vec{a}_1}{\vec{a}_1 \cdot (\vec{a}_2 \times \vec{a}_3)} \, = & 3.939 \, \hat{k}_x \, + \, 2.275 \, \hat{k}_y \, + \, 0.000 \, \hat{k}_z \, [\mathrm{m}^{-1}] \\ \vec{b}_3 &= 2\pi \, \frac{\vec{a}_1 \times \vec{a}_2}{\vec{a}_1 \cdot (\vec{a}_2 \times \vec{a}_3)} \, = & 0.000 \, \hat{k}_x \, + \, 0.000 \, \hat{k}_y \, + \, 1.212 \mathrm{e} + 10 \, \hat{k}_z \, [\mathrm{m}^{-1}] \end{split}$$

$n_{ec{G}} = \sum_{j} Z_{j} \exp(-i ec{G} \cdot ec{r}_{j}).$

Structure factors

The value of $|n_{\vec{G}}|$ for the 000 diffraction peak is the total number of electrons in the primitive unit cell. The intensities of the peaks in an x-ray diffraction experiment are proportional to $|n_{\vec{G}}|^2$. Note that elements with more electrons produce stronger diffraction intensities.

hkl	$ ec{G} $ $ m \AA^{-1}$	$ n_{\tilde{G}} $	$ n_{\tilde{G}} ^2$	$\operatorname{Re}\{n_{\tilde{G}}\}$	$\operatorname{Im}\{n_{\tilde{G}}\}$
000	0.000	75.94	5767	75.94	0.000
0-10	4.549e-10	37.87	1434	-37.87	0.02201
010	4.549e-10	37.87	1434	-37.87	-0.02201
0-20	9.098e-10	38.17	1457	-38.17	0.04379
020	9.098e-10	38.17	1457	-38.17	-0.04379
0-30	1.365e-9	75.94	5767	75.94	-0.1318
030	1.365e-9	75.94	5767	75.94	0.1318
0-3-1	1.212	0.3909	0.1528	0.02780	0.3899
0-31	1.212	0.3914	0.1532	-0.02727	0.3904
0-2-1	1.212	42.85	1836	-7.648	42.16
0-21	1.212	42.74	1827	7.551	42.07
0-1-1	1.212	43.01	1850	7.610	-42.33
0-11	1.212	42.96	1845	7,561	-42.29
00-1	1.212	8.896e-8	7.914e-15	-1.573e-8	8.756e-8
001	1.212	8.896e-8	7.914e-15	-1.573e-8	-8.756e-8
01-1	1.212	42.96	1845	-7.561	42.29
011	1.212	43.01	1850	7.610	42.33
02-1	1.212	42.74	1827	7.551	-42.07
021	1.212	42.85	1836	-7.648	-42.16
∩3 _− 1	1 212	∩ 391⊿	n 1539	_0 02727	_N 39N4

Neutron diffraction

Typically a nuclear reactor is used as the neutron source

There are different atomic form factors for neutrons than for x-rays.

Determine the positions of H in biological samples.

Can for example distinguish between Fe and Co which have similar atomic form factors for x-rays.

Atomic beams

Hydrogen and Helium are used for diffraction studies

$$E = \frac{1}{2}mv^2 = \frac{p^2}{2m} = \frac{\hbar^2 k^2}{2m} = \frac{h^2}{2m\lambda^2}$$

Low energies can be used for delicate samples. Measure the surface like LEED.